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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/043,023	01/08/2002	Willys Choi	67,200-616	6137
7590 03/22/2004			EXAMINER	
TUNG & ASSOCIATES Suite 120			РНАМ, НОА Q	
838 W. Long Lake Road			ART UNIT	PAPER NUMBER
Bloomfield Hills, MI 48302			2877	
			DATE MAILED: 03/22/2004	

Please find below and/or attached an Office communication concerning this application or proceeding.

	Application No.	Applicant(a)				
	Application No.	Applicant(s)				
Office Action Summary	10/043,023	CHOI, WILLYS				
Office Action Summary	Examiner	Art Unit				
	Hoa Q. Pham	2877				
The MAILING DATE of this communication ap Period for Reply	ppears on the cover sheet with the c	orrespondence address				
A SHORTENED STATUTORY PERIOD FOR REPL THE MAILING DATE OF THIS COMMUNICATION.  - Extensions of time may be available under the provisions of 37 CFR 1. after SIX (6) MONTHS from the mailing date of this communication.  - If the period for reply specified above is less than thirty (30) days, a replied of the period for reply is specified above, the maximum statutory period.  - Failure to reply within the set or extended period for reply will, by statut Any reply received by the Office later than three months after the mailing earned patent term adjustment. See 37 CFR 1.704(b).		nely filed s will be considered timely. the mailing date of this communication. D (35 U.S.C. § 133).				
Status						
1) Responsive to communication(s) filed on 22 t	December 2003.					
<u>_</u>	is action is non-final.					
,	Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under <i>Ex parte Quayle</i> , 1935 C.D. 11, 453 O.G. 213.					
Disposition of Claims						
4) ☐ Claim(s) 1-13,15-27 and 29-32 is/are pending 4a) Of the above claim(s) is/are withdra 5) ☐ Claim(s) is/are allowed.  6) ☐ Claim(s) 1-13,15-27 and 29-32 is/are rejected 7) ☐ Claim(s) is/are objected to.  8) ☐ Claim(s) are subject to restriction and/	awn from consideration.					
Application Papers						
9)☐ The specification is objected to by the Examin	ner.					
10)☐ The drawing(s) filed on is/are: a)☐ accepted or b)☐ objected to by the Examiner.						
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).						
Replacement drawing sheet(s) including the correct 11) The oath or declaration is objected to by the E						
Priority under 35 U.S.C. § 119						
12) Acknowledgment is made of a claim for foreig  a) All b) Some * c) None of:  1. Certified copies of the priority document  2. Certified copies of the priority document  3. Copies of the certified copies of the priority document  application from the International Bureat  * See the attached detailed Office action for a list	nts have been received. Ints have been received in Applicati ority documents have been receive au (PCT Rule 17.2(a)).	on No ed in this National Stage				
Attachment(s)  1) Motion of Poforonces Cited (PTO 892)	4) Interview Summary	(PTO-413)				
<ol> <li>Notice of References Cited (PTO-892)</li> <li>Notice of Draftsperson's Patent Drawing Review (PTO-948)</li> <li>Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08 Paper No(s)/Mail Date</li> </ol>	Paper No(s)/Mail Da	· ·				

## **DETAILED ACTION**

## Claim Rejections - 35 USC § 103

- 1. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
  - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 2. Claims 1-13, 15-27, and 29-32 are rejected under 35 U.S.C. 103(a) as being unpatentable over Urayama et al (JP-40-5217881 A) in view of Fitzsimmons et al (6,493,078) and Nakano et al (6,613,588).

Regarding claims 1, 14-16, 17, and 29-30; Urayama et al discloses a resist coater with an evaluation unit for detecting dust quantity of resist film on the wafer which has all the features of the present invention except that the coater cup is comprises a transparent material; however, such a feature is known in the art, for example, as taught by Fitzsimmons et al. Fitzsimmon et al, from the same field of the endeavor, teaches that the a part of the coater bowl (105) is made of transparent material (transparent window)(120,220,32) so that the detector (131) is located outside of the chamber for monitoring the substrate (115) (figures 2, 3, 5, 6, 9 and column 4, lines 29-31 and column 6, lines 40-42). It would have been obvious to one having ordinary skill in the art at the time the invention was made to modify the device of Urayama et al by using a transparent material for the coater bowl as taught by Fitzsimmons et al so that the light source and the detector are located outside of the coater. The rationale for this modification would have arisen from the fact that by using a transparent material or

Application/Control Number: 10/043,023

Art Unit: 2877

window for the coater and positioning the detector and light source outside of the coater would prevent the damages of the light source and detector due to the heat, dirt and moisture inside the coater.

Urayama et al does not teach that the coating device is automatically terminated when the amount of the dust is exceeded a predetermined level. However, such a feature is known in the art as taught by Nakano et al. Nakano et al teaches that the plasma processing device with a particle detection optical system in which the etching operation can be halted if the total number of particles generated exceeds a reference value (column 9, lines 21-27 and column 18, lines 44-52). It would have been obvious to one having ordinary skill in the art to include in Urayama et al a terminating system as taught by Nakano et al. The rationale for this modification would have arisen from the fact that using such system would alert the operator know when the processing chamber need to be cleaned or maintenance.

Regarding claim 3, the laser source is attached to the coater cup (see figure 1).

Regarding claims 4 and 18, see Urayama's abstract for resist coater.

Regarding claims 2, 5-7,12-13, 19-21, 26-27, see Urayama's abstract for a laser source (10) and a laser detector (11). Thus, it would have been obvious to one having ordinary skill in the art at the time the invention was made to use an edge emitting laser or a solid-state semiconductor light emitter because they would function in the same manner. A substitution one for another is generally recognized as being within the level of ordinary skill in the art.

Regarding claims 8 and 22, see figure 1 of Urayama for spindle (15).

Application/Control Number: 10/043,023

Art Unit: 2877

Regarding claims 9 and 23, see Urayama's abstract for detecting dust.

Regarding claims 10, 11, and 24-25, it would have been obvious to one having ordinary skill in the art at the time the invention was made to use the particle detection system of Urayama et al for detecting the photoresist dust as a result of a wafer spin coating operation because the device would function in the same manner.

Regarding claims 31 and 32, it would have been obvious to one having ordinary skill in the art at the time the invention was made to include in Urayama one or more additional coater bowl if addition inspection is desired.

3. Applicant's arguments with respect to claims 1-13, 15-27, 29-32 have been considered but are moot in view of the new ground(s) of rejection.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Hoa Q. Pham whose telephone number is (571) 272-2426. The examiner can normally be reached on 7:30AM to 6 PM, Monday through Thursday.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Frank G. Font can be reached on (571) 272-2415. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Art Unit: 2877

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Hoa Q. Pham

**Primary Examiner** 

Art Unit 2877

HP

March 11, 2004